

# 6AM13

Silicon N-Channel/P-Channel Complementary Power MOS FET  
Array

**HITACHI**

ADE-208-1217 (Z)  
1st. Edition  
Mar. 2001

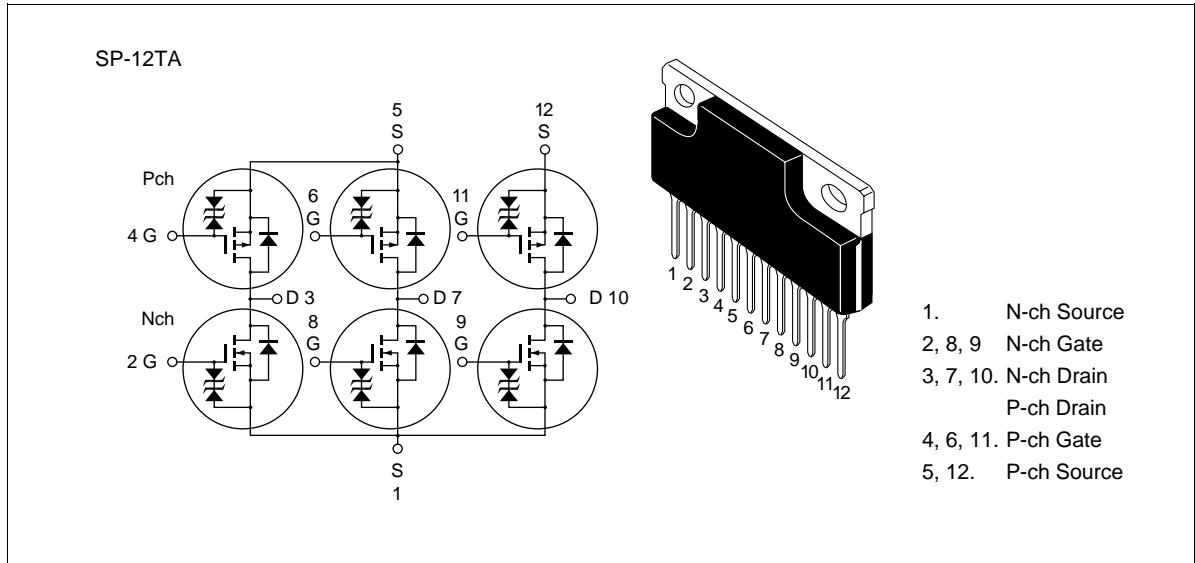
## Application

High speed power switching

## Features

- Low on-resistance  
N-channel:  $R_{DS(on)} \leq 0.075$  ,  $V_{GS} = 10$  V,  $I_D = 5$  A  
P-channel:  $R_{DS(on)} \leq 0.12$  ,  $V_{GS} = -10$  V,  $I_D = -5$  A
- Capable of 4 V gate drive
- Low drive current
- High speed switching
- High density mounting
- Suitable for H-bridged motor driver

## Outline



## Absolute Maximum Ratings (Ta = 25°C)

Item	Symbol	Ratings		
		Nch	Pch	Unit
Drain to source voltage	V <sub>DSS</sub>	60	-60	V
Gate to source voltage	V <sub>GSS</sub>	±20	±20	V
Drain current	I <sub>D</sub>	10	-10	A
Drain peak current	I <sub>D(pulse)</sub> <sup>*1</sup>	40	-40	A
Body to drain diode reverse drain current	I <sub>DR</sub>	10	-10	A
Channel dissipation	Pch (Tc = 25°C) <sup>*2</sup>	42		W
Channel dissipation	Pch <sup>*2</sup>	4.8		W
Channel temperature	T <sub>ch</sub>	150		°C
Storage temperature	T <sub>stg</sub>	-55 to +150		°C

Notes: 1. PW ≤ 10 µs, duty cycle ≤ 1%

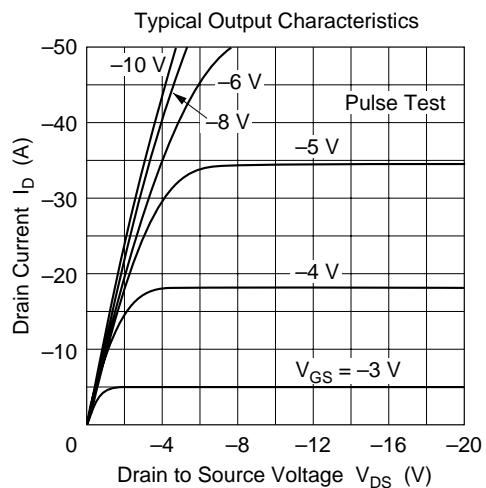
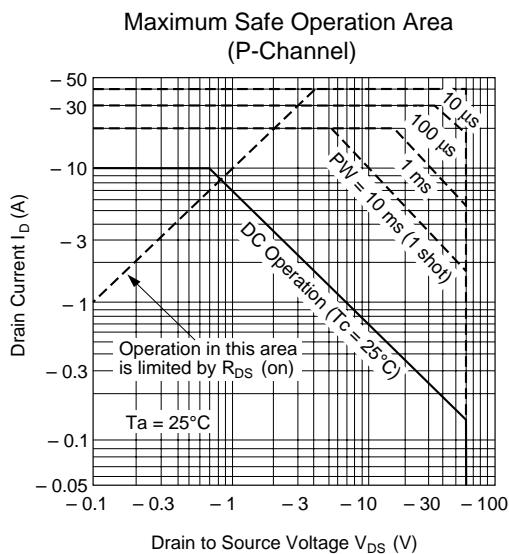
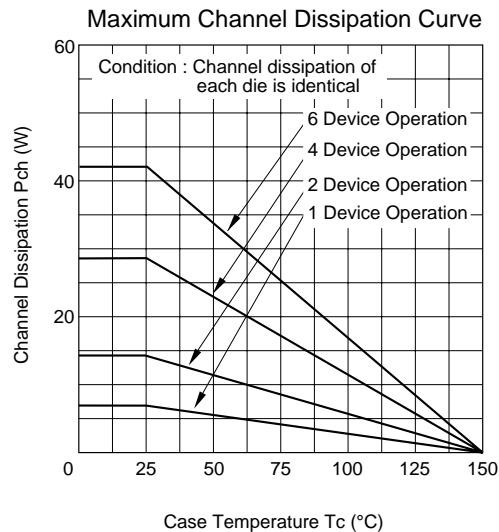
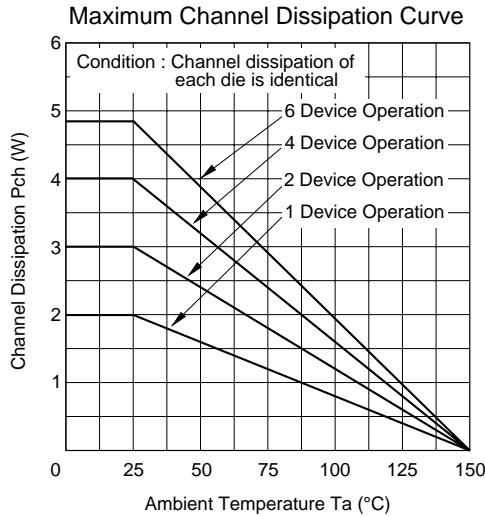
2. 6 devices operation

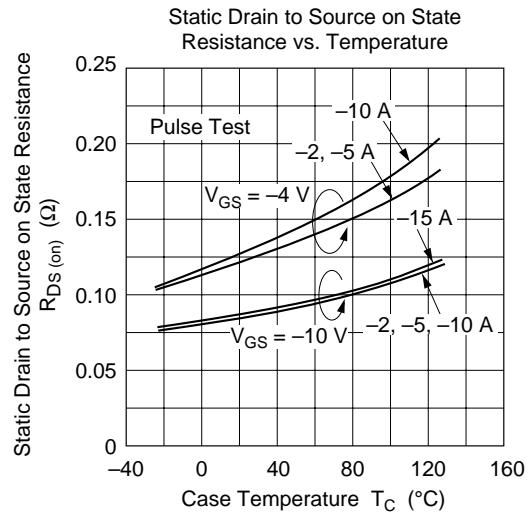
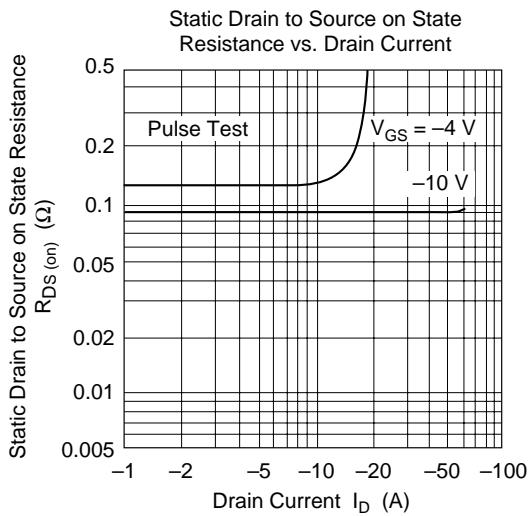
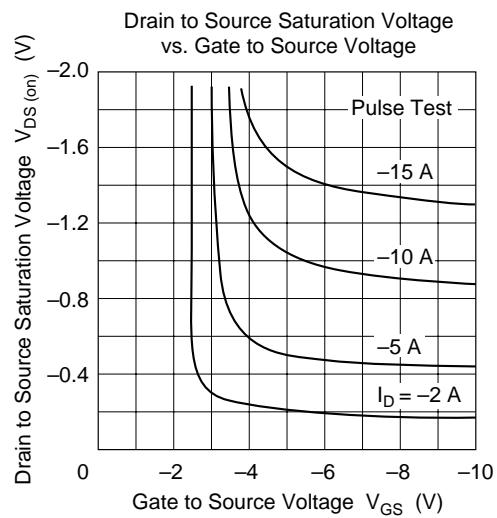
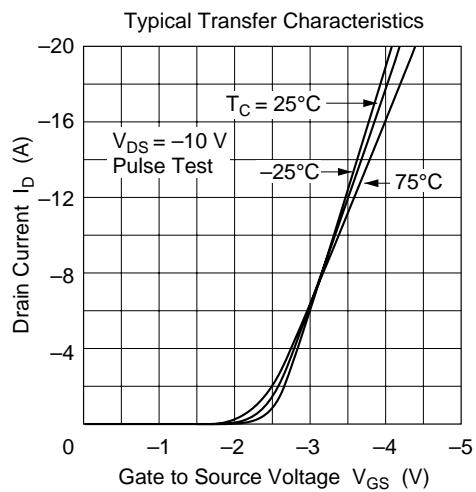
**Electrical Characteristics (Ta = 25°C) (1 Unit)**

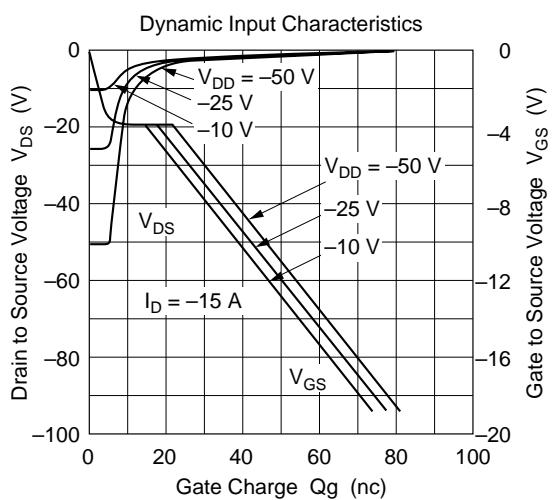
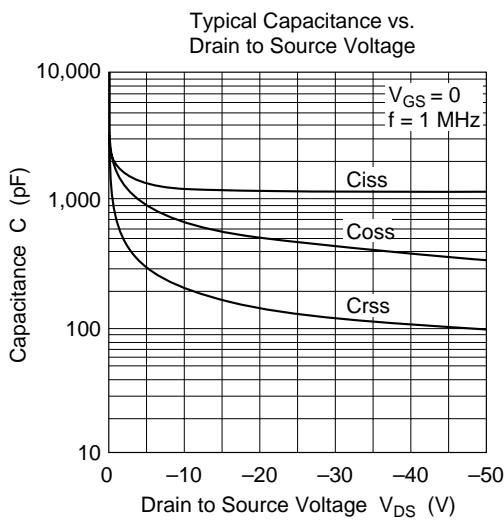
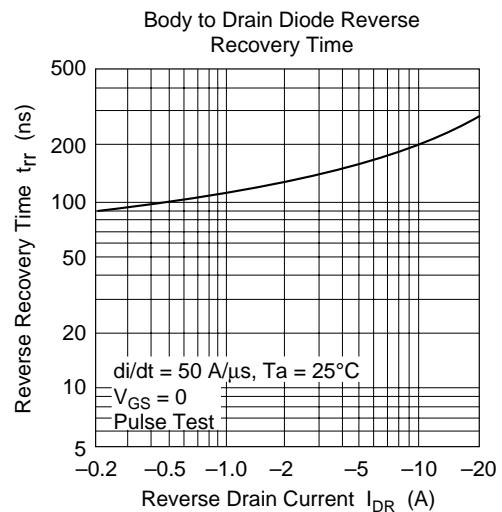
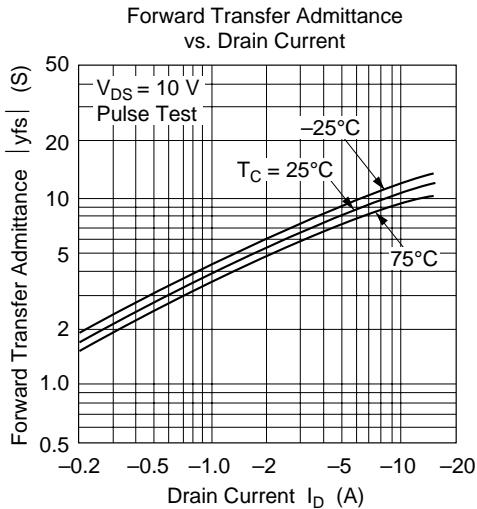
Item	Symbol	N channel			P channel			Unit	Test conditions
		Min	Typ	Max	Min	Typ	Max		
Drain to source breakdown voltage	V <sub>(BR)DSS</sub>	60	—	—	-60	—	—	V	I <sub>D</sub> = 10 mA, V <sub>GS</sub> = 0
Gate to source breakdown voltage	V <sub>(BR)GSS</sub>	±20	—	—	±20	—	—	V	I <sub>G</sub> = ±100 µA, V <sub>DS</sub> = 0
Gate to source leak current	I <sub>GSS</sub>	—	—	±10	—	—	±10	µA	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0
Zero gate voltage drain current	I <sub>DSS</sub>	—	—	250	—	—	-250	µA	V <sub>DS</sub> = 50 V, V <sub>GS</sub> = 0
Gate to source cutoff voltage	V <sub>GS(off)</sub>	1.0	—	2.0	-1.0	—	-2.0	V	I <sub>D</sub> = 1 mA, V <sub>DS</sub> = 10 V
Static drain to source on state resistance	R <sub>DS(on)</sub>	—	0.06	0.075	—	0.09	0.12	Ω	I <sub>D</sub> = 5 A, V <sub>GS</sub> = 10 V <sup>*1</sup>
		—	0.08	0.11	—	0.12	0.18	Ω	I <sub>D</sub> = 5 A, V <sub>GS</sub> = 4 V <sup>*1</sup>
Forward transfer admittance	y <sub>fs</sub>	6	9.5	—	5	8	—	S	I <sub>D</sub> = 5 A, V <sub>DS</sub> = 10 V <sup>*1</sup>
Input capacitance	C <sub>iss</sub>	—	860	—	—	1400	—	pF	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0,
Output capacitance	C <sub>oss</sub>	—	450	—	—	720	—	pF	f = 1 MHz
Reverse transfer capacitance	C <sub>rss</sub>	—	140	—	—	220	—	pF	
Turn-on delay time	t <sub>d(on)</sub>	—	10	—	—	15	—	ns	I <sub>D</sub> = 5 A, V <sub>GS</sub> = 10 V,
Rise time	t <sub>r</sub>	—	50	—	—	100	—	ns	R <sub>L</sub> = 6 Ω
Turn-off delay time	t <sub>d(off)</sub>	—	180	—	—	250	—	ns	
Fall time	t <sub>f</sub>	—	110	—	—	160	—	ns	
Body to drain diode forward voltage	V <sub>DF</sub>	—	1.0	—	—	-1.0	—	V	I <sub>F</sub> = 10 A, V <sub>GS</sub> = 0
Body to drain diode reverse recovery time	t <sub>rr</sub>	—	120	—	—	200	—	ns	I <sub>F</sub> = 10 A, V <sub>GS</sub> = 0, dI/dt = 50 A/µs

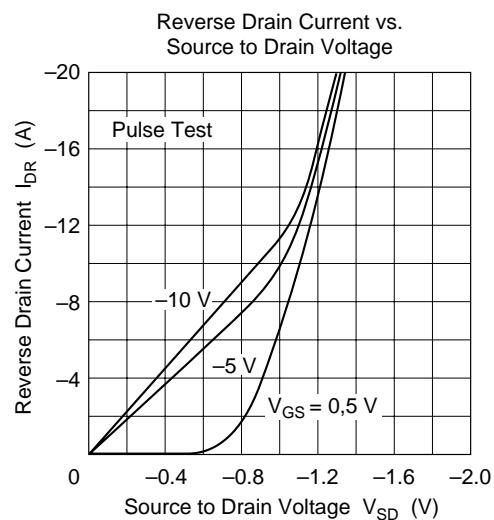
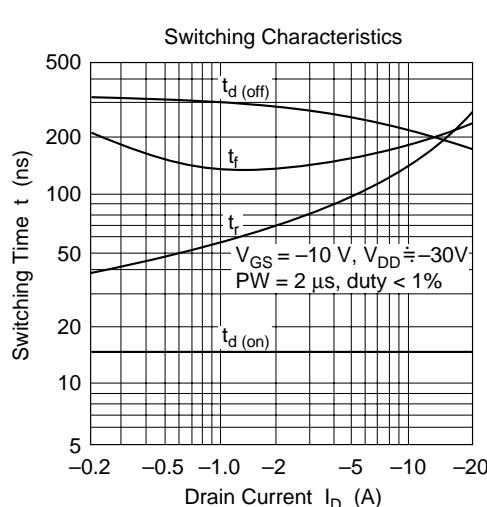
Note: 1. Pulse Test

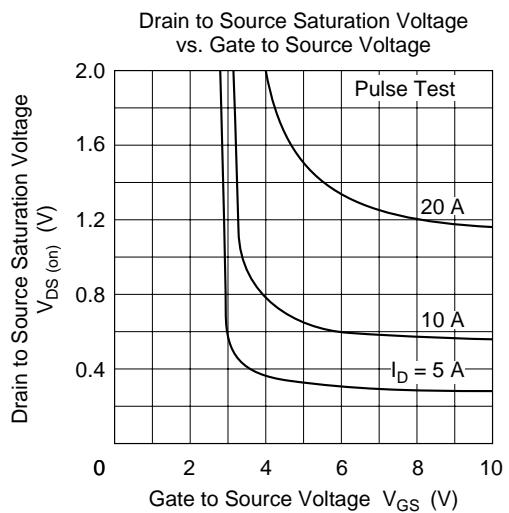
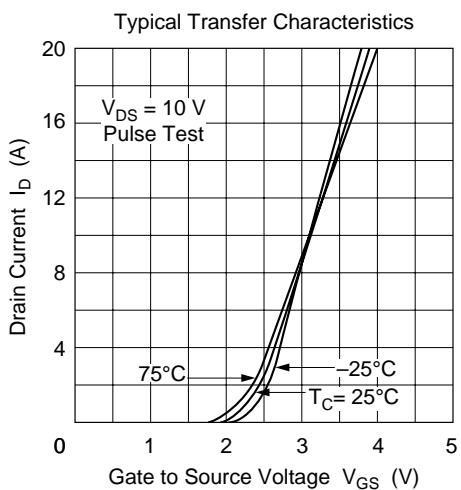
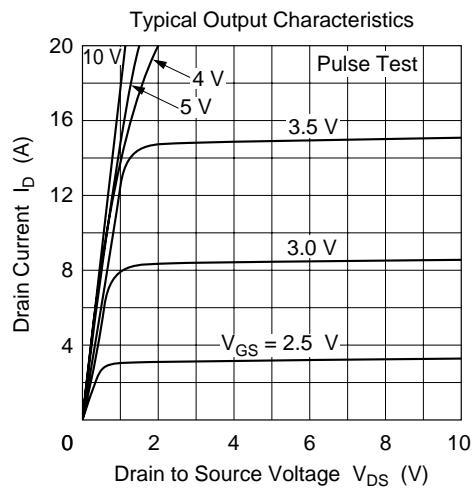
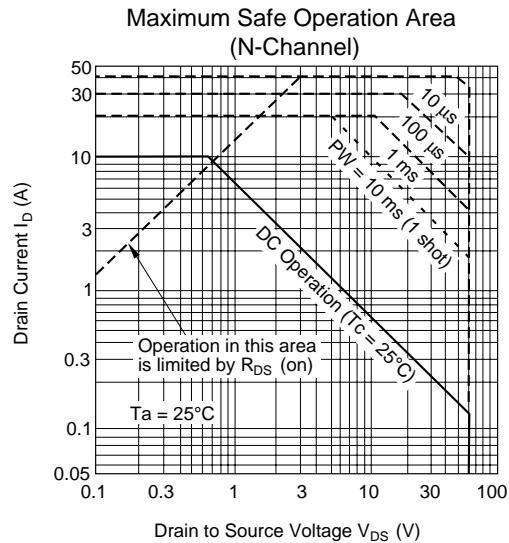
Polarity of test conditions for P channel device is reversed.

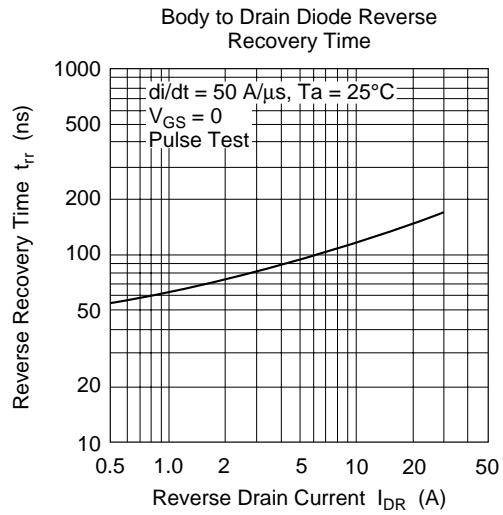
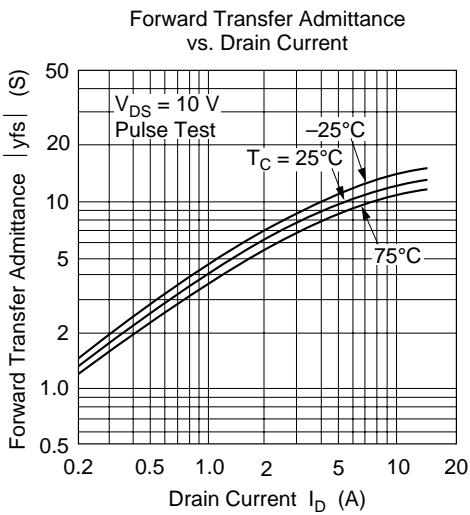
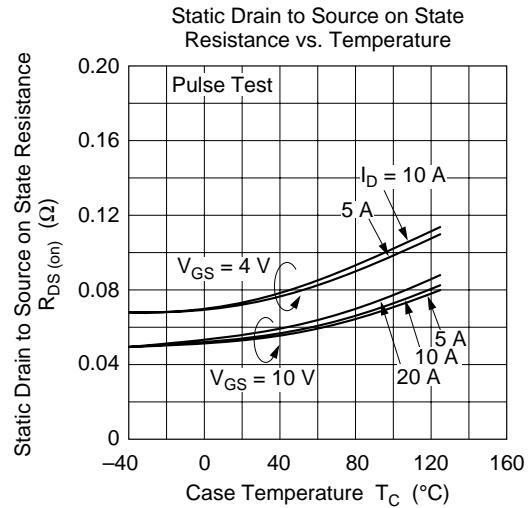
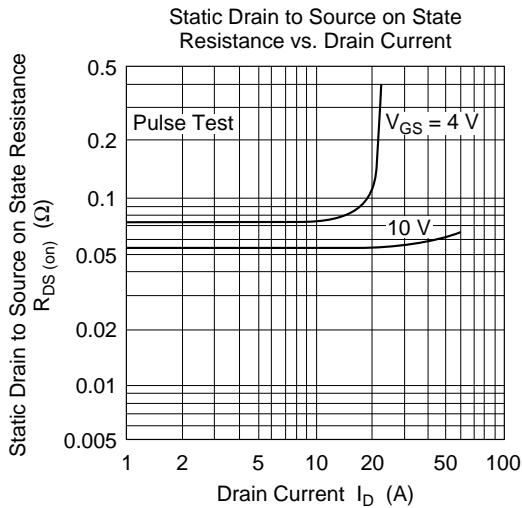


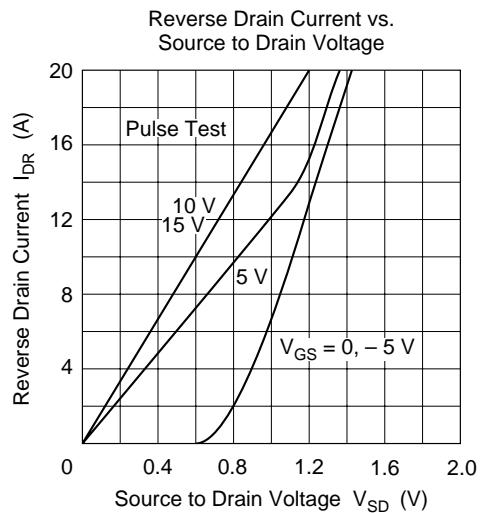
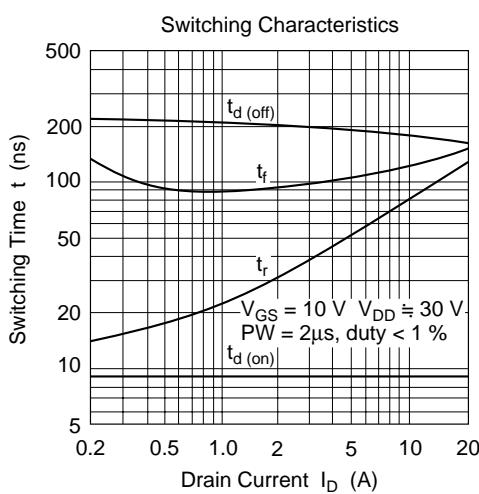
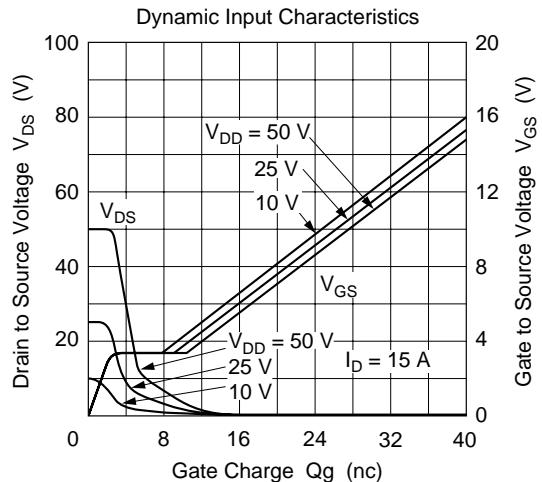
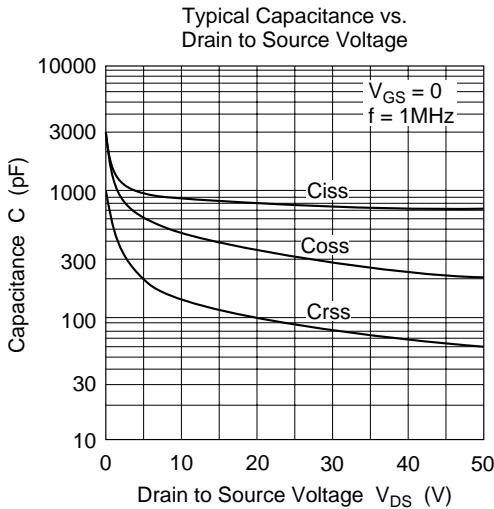






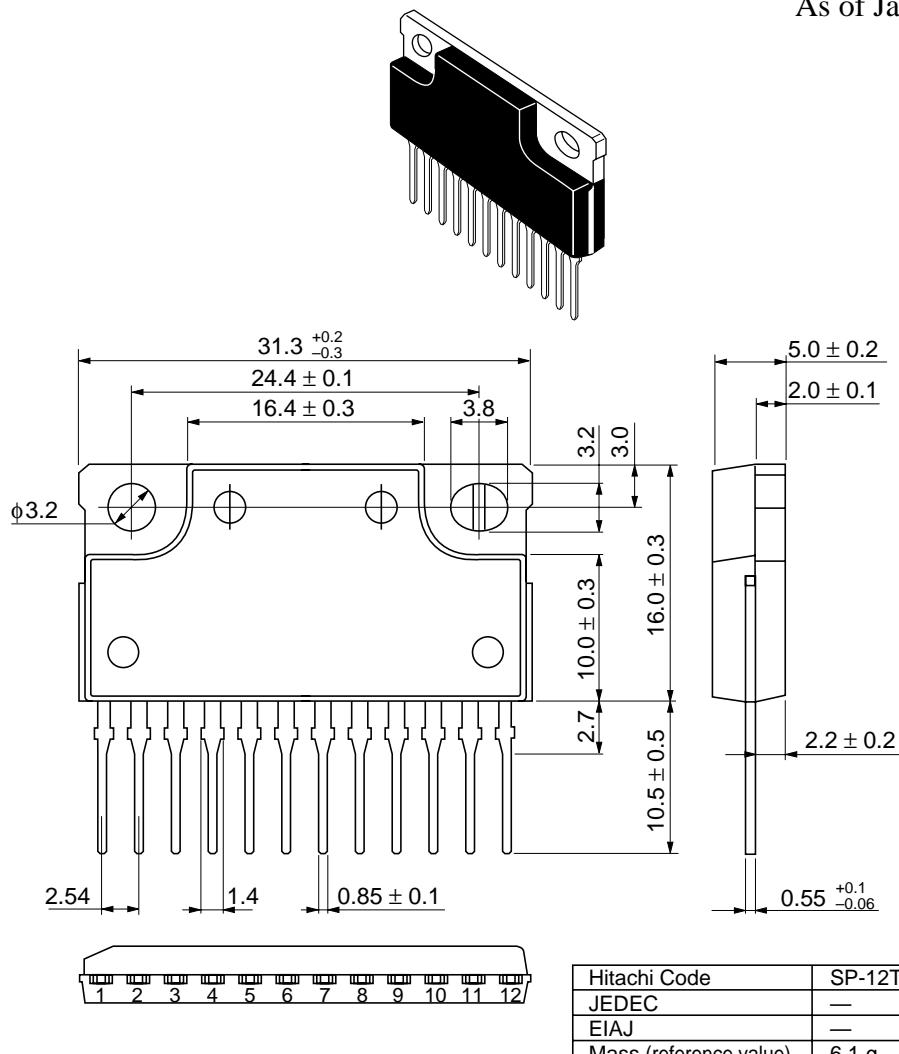






## Package Dimensions

As of January, 2001  
Unit: mm



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